

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/665,910	KUDO ET AL.	
Examiner	Art Unit	
Kevin M. Bernatz	1773	

SEARCHED					
Class	Subclass	Date	Examiner		
					
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
inventor scorls (attacks)	5/10/06	MB